

Notice of References Cited	Application/Control No. 10/519,266	Applicant(s)/Patent Under Reexamination FEKETE ET AL.	
	Examiner Christopher S. Kim	Art Unit 3752	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	DE 199 54 537 A1	05-2001	Germany	Ruechle et al.	---
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NON-PATENT DOCUMENTS

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